COMMERCIAL MICRO-D CONNECTOR SYSTEM

1.0 SCOPE

This Product Specification covers the 1.27 mm (.050 inch) centerline Commercial Micro-D connector series, including both printed circuit board header connector styles and cable connector series, terminable to 26 or 28 AWG shielded cable

2.0 PRODUCT DESCRIPTION

mole

2.1 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS PRODUCT NAME AND PART NUMBERS

The following product names and series numbers are covered by this specification:

Headers w/wo jackposts, Size 9 Headers w/wo jackposts, Size 15 Headers w/wo jackposts, Size 25 Dual Stack Headers w/wo jackposts Shielded Cable Connector, Size 9 Shielded Cable Connector, Size 15 Shielded Cable Connector, Size 25 Series 83611 Series 83612 Series 83614 Series 83619 Series 83421 Series 83422 Series 83424

2.2

Refer to the associated Sales Drawings for additional information on configurations, dimensions, materials, platings and markings.

CONNECTOR CONFIGURATIONS

Connectors and headers are available in a variety of configurations, stamped one-piece pin contacts, and jackpost configurations, which will accept 2-56 or 4-40 threaded jackscrews.

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	T SPECIFICATION	FOR	SHEET No.
Q	<u>EC No:</u> IPG2013-0888	СОМІ	MERCIAL MICRO-	D	1 of 16
-	DATE: 2012/12/12	CON	NECTOR SYSTEM	1	
DOCUMEN	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	<u>APPRO\</u>	/ED BY:
P	S-83421-001	A.WILSON	A.WILSON	F.MAL	CZYK
			TEMPI ATE EII ENA	ME PRODUCT SPEC	ISIZE AI(V 1) DOC



2.3 DESIGN FEATURES

MATERIALS AND PLATINGS

Pin Contacts	15μin min gold over 30μin min nickel in mating area and 20μin min matte tin over 50μin min nickel on the solder tail. Base material is a copper alloy.
Socket Contacts	15 or 30 μin min gold over 50μin min nickel. Base material is a copper alloy.
Insulators	Injection molded LCP, UL 94V-0
Shells	150µin nickel over alloy steel.
Backshells	100µin nickel over alloy steel with PVC overmold or Optional rubber boot. Color black
CABLE	
Configuration	Max 25 conductors with braided copper shield and with overall jacket.
Outer diameter	0.225-inch nominalfor Size 90.264-inch nominalfor Size 150.311-inch nominalfor Size 25
Overall jacket	Material optional
Conductors	28 AWG (7 strands of 36 AWG) 26 AWG (7 strands of 34 AWG)

2.4 SAFETY AGENCY APPROVAL

The following approvals are applicable to the connectors and cable assemblies covered by this specification:

UL Recognition	UL File Number	E34763
----------------	----------------	--------

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	T SPECIFICATION	FOR	SHEET No.
Q	<u>EC No:</u> IPG2013-0888 DATE: 2012/12/12		MERCIAL MICRO- NECTOR SYSTEM		2 of 16
DOCUMENT	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS	6-83421-001	A.WILSON	A.WILSON	F.MAL	CZYK
		·	TEMPLATE FILENA	ME: PRODUCT_SPEC	S[SIZE_A](V.1).DOC



3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

3.1 The connectors and cable assemblies covered by this specification are commercial versions, designed and tested to meet MIL-specification and performance standards and comply with the requirements of the following standards

3.2 MIL-DTL-83513	DETAIL SPECIFICATION—MICRO MINIATURE, RECTANGLAR CONNECTORS
MIL-STD-1344	TEST METHODS FOR ELECTRICAL CONNECTORS
UL 1977	STANDARD FOR SAFETY—COMPONENT CONNECTORS
APPLICATIONS	Used in Data, Signal, Control and Power

4.0 RATINGS

4.1 ELECTRICAL

DIELECTRIC WITHSTANDING	600 V _{AC} Reference: MIL-DTL-83513 Rev. G Section 3.5.4
VOLTAGE (DWV) (Sea Level)	

OPERATING VOLTAGE: 30 V_{RMS} (42 P_{eak}) Reference: UL 1977 Section 1.2

1A at 25 C 77 F, 0.7A at 70 C, 158 F

CURRENT RATING

4.2 ENVIRONMENTAL

Shock	half sine, 50g, 11ms duration
Vibration resistance	10-500Hz @ 5g accel
Thermal Cycling	-55°C to +125°C
Contact durability	500 cycles minimum
Contact Engagement Force	0.15N to 2.4N (0.5 oz Min to 8.6 oz Max) per contact.

Contact retention

5.0 lb min per Method 2007 of MIL-STD-1344

21 DAYS PER METHOD 1002 OF MIL-STD-1344

HUMIDITY @ 95%

4.3 TEMPERATURE Operating: -40°C to + 125°C Nonoperating:-55°C to + 85°C

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	T SPECIFICATION	FOR	SHEET No.
Q	<u>EC No:</u> IPG2013-0888	COMI	MERCIAL MICRO-	D	3 of 16
-	<u>DATE:</u> 2012/12/12	CON	NECTOR SYSTEM	1	3 01 10
DOCUMENT	NUMBER:	CREATED / REVISED BY: CHECKED BY: APPROVED BY:			
PS-83421-001		A.WILSON	A.WILSON	F.MAL	СΖҮК

TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOC



5.0 PERFORMANCE

This paragraph defines the tests to be performed, and the sequence in which they are to be performed. Unless otherwise specified, all tests shall be carried out under standard atmospheric conditions for testing. Unless otherwise defined, mated sets of connector parts shall be tested. Care shall be taken to keep a particular combination of connector pairs together during the complete sequence

Before commencing any testing, all specimens shall be stored for at least 24 hours in the non-inserted state (unmated) under normal atmospheric conditions. The following tests, a mated connector pair is called a specimen. When the Initial Tests have been completed, all specimens shall be divided up according to the test groups noted, in the quantities noted.

5.1

NUMBER OF TEST SPECIMENS

TEST GROUP	TABLE NO.	NO. OF SPECIMEN
INITIAL	I	13
SHOCK & VIB	А	4
MECHANICAL	В	4
HUMIDITY	С	4

 TABLE I: TEST GROUP – INITIAL
 **
 This test must be performed before crimping of backshell

PHASE	TEST	TEST CONDITION	MEASUREMENT	REQMT SPEC.	REQUIREMENT
1	Initial Measurement	Unmated Connectors	Visual		No defects that impair normal operation
1a		Unmated Connectors	Dimensional	Product Drawing	No deviations from dimensional tolerances
2		Unmated Connectors	Polarization	Product Drawing	Connectors shall mate in the correct manner
3	**	Unmated Connectors See Fig. 1	Contact Resistance. MIL-STD- 1344 METHOD 3002	20mV max @ 100mA (Kelvin 4- wire test)	C.R.=8mΩ max thru p/s interface & socket crimp
4		Unmated Connectors	Insulation Resistance MIL- STD-1344 METHOD 3002	500 ± 15VDC,	I.R. to be >5 x 10 ⁹ Ω
5		Unmated Connectors	Voltage proof (DWV) MIL- STD-1344 METHOD 3001, TEST COND I	630 Vac min	No breakdown, flashover or leakage >1mohm

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	T SPECIFICATION	FOR	SHEET No.
Q	<u>EC No:</u> IPG2013-0888	COMI	MERCIAL MICRO-	D	4 of 16
	<u>DATE:</u> 2012/12/12	CON	NECTOR SYSTEM	1	- 01 10
DOCUMEN	NUMBER:	CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
P	S-83421-001	A.WILSON	A.WILSON	F.MAL	CZYK

TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOC



5.2 TABLE A: TEST GROUP - SHOCK AND VIBRATION

PHASE	TEST	TEST CONDITION	MEASURE- MENT	REQMT SPEC.	REQUIREM	ENT
1		Unmated Connectors	Gage	4 contacts/	0.5oz min	
		See Fig. 2	retention force		withdrawal /	
2		Mated Connectors	Connector	10mm/sac,		DSITION
		See Fig. 5	mate/unmate	Measured in	<u>9</u> Max Mating165	178 238
2	Vibration**	$\Gamma_{rog} = 10 E00 II =$	force	0Z.	MinUnmating 2	
3	MIL-STD- 1344	Freq = 10-500 Hz 5g acceleration	Contact resistance,	20 mA, 20 mV	change from	
	METHOD 2005,	Duration = 2hrs/axis	resistance,		C.R. meas.	
	COND II	Conn. mounting per			Table I. Con	
		Fig3	Contact		intermittence	e to be
4	Mechanical	Acceleration = 50 g	Contact	100mA, 20mV		
	Shock** MIL-	duration = 11 ms, 10	resistance		from init. C.I	
	STD-1344	shocks, 5 in each axis,	Contect		meas. in Tal intermittence	
	METHOD 2004	half sine. Connector mounting per Fig. 3.	Contact intermittence		microsec. Int	
_		0.0			C.R. >500 of	
5	Thermal	Mated connectors. 5				
	Shock** MIL- STD-1344	cycles. Temp°C/Dur.min -55+/-				
	METHOD 1003	3/30;+25 +/-10 /5;				
	COND A	+125+/-3/30; +25+/-10				
		/5				
6		Unmated connectors	Insulation	Test voltage	I.R. to be >5	5 x10 ⁹ Ω
			resistance	500 +/-15V.		
7		Unmated connectors	Withstanding	Apply 630 V	No breakdov	
			voltage (DWV)	min	flashover, or leakage >1n	
8		Unmated connectors	Contact	20mV max @	C.R.= $8m\Omega$ r	
~		See Fig. 1**	resistance	100mA (Kelvin	change from	-
				4-wire test)		
9		Unmated connectors	Visual exam		No evidence	
					damage that	
					affect perfor	
	is test the contact re accounted for.	esistance may be measured	through the cabl	le, if the bulk resis	tance of the c	able has
DUGIT C						
	ECR/ECN INFORMA		DUCT SPE	CIFICATION	FOR	SHEET
Q	<u>EC No:</u> IPG2013-08	000		AL MICRO-		E . C
~	DATE: 2012/12/12		-	OR SYSTEM		5 of '
CUMENT	NUMBER:	CREATED / REVISE	r	ECKED BY:	APPROV	ED BY:
PS	-83421-001	A.WILSON	A	.WILSON	F.MAL	CZYK

molex®

PRODUCT SPECIFICATION

5.3 TABLE B; TEST GROUP - MECHANICAL CYCLING AND HUMIDITY

PHASE	TEST CONDITION	TEST CONDITION	MEASURE- MENT	REQMT SPEC	REQUIREMENT
1	Durability	Speed 10mm/sec 500 cycles, 30 seconds rest in unmated condition		0.05 min electrical engagement/ cycle	
2		Unmated Connectors	Insulation resistance	Test voltage 500 +/-15V.	I.R. to be >5 $\times 10^{9}\Omega$
3		Unmated Connectors	Withstanding voltage (DWV)	630 V min	No breakdown, flashover, or leakage >1mohm .
4		Unmated Connectors See Fig. 1**	Contact resistance	20mV max @100mA (Kelvin 4-wire test)	C.R.=35m Ω max change from initial
5		Unmated Connectors See Fig. 2	Gage retention force	4 contacts/ conn. See Fig 2	0.5oz min withdrawal /contact
6		Unmated Connectors	Visual exam		No evidence of damage that will affect performance
7	Static Load, axial	Mated Connectors See Fig. 4	Connector pulloff	2 conn/lot. Application rate 2.25lb/sec. Total force 25 lb min	No evidence of damage that will affect performance
8	Cable Retention Cable assy only	Fig. 4 except no jackscrews and anchor clamp to front shell flange	Cable pullout	2 conn/lot. Application rate 2.25lb/ sec. Total force 25 lb min	No evidence of damage that will affect performance
9		Unmated Connectors	Withstanding voltage (DWV)	630 v min	No breakdown, flashover, or leakage >1mohm .

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	SPECIFICATION	FOR	SHEET No.
Q	<u>EC No:</u> IPG2013-0888	COMM	6 of 16		
	DATE: 2012/12/12	CON	NECTOR SYSTEM		
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	<u>APPROV</u>	/ED BY:
PS	5-83421-001	A.WILSON	A.WILSON	F.MAL	CZYK
		•	TEMPLATE FILENA	ME: PRODUCT_SPEC	[SIZE_A](V.1).DOC



5.4 TABLE C: GROUP - CONTACT RESISTANCE AND HUMIDITY

PHASE	TEST CONDITION	TEST CONDITION	MEASURE- MENT	REQMT SPEC.	REQUIREMENT
1	Humidity	Mated Connectors MIL- STD-1344 METHOD 1002, TYPE I COND C		2hr drying time.	
2		Unmated Connectors	Insulation resistance	500 +/-15Vdc	I.R. to be >5 x10 ⁹ Ω
3		Unmated Connectors	Withstanding voltage (DWV)	630 v min	No breakdown, flashover, or leakage >1mohm
4		Unmated Connectors See Fig. 1**	Contact resistance	20mV max @100mA (Kelvin 4-wire test)	C.R.=8mΩ max change from initial
5		Unmated Connectors See Fig. 2	Gage retention force	4 contacts/ conn. See Fig 2	0.5oz min withdrawal /contact
6		Unmated Connectors	Visual exam		No evidence of damage that will affect performance

NOTE: ** For this test the contact resistance may be measured through the cable, if the bulk resistance of the cable has been accounted for

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	T SPECIFICATION	FOR	SHEET No.
Q	<u>EC No:</u> IPG2013-0888	COMI	MERCIAL MICRO-	D	7 of 16
-	<u>DATE:</u> 2012/12/12	CON	NECTOR SYSTEM	1	1 01 10
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:
PS-83421-001		A.WILSON	A.WILSON	F.MAL	CZYK
TEMPLATE FILENAME: PRODUCT_SPEC[SIZE_A](V.1).DOC					



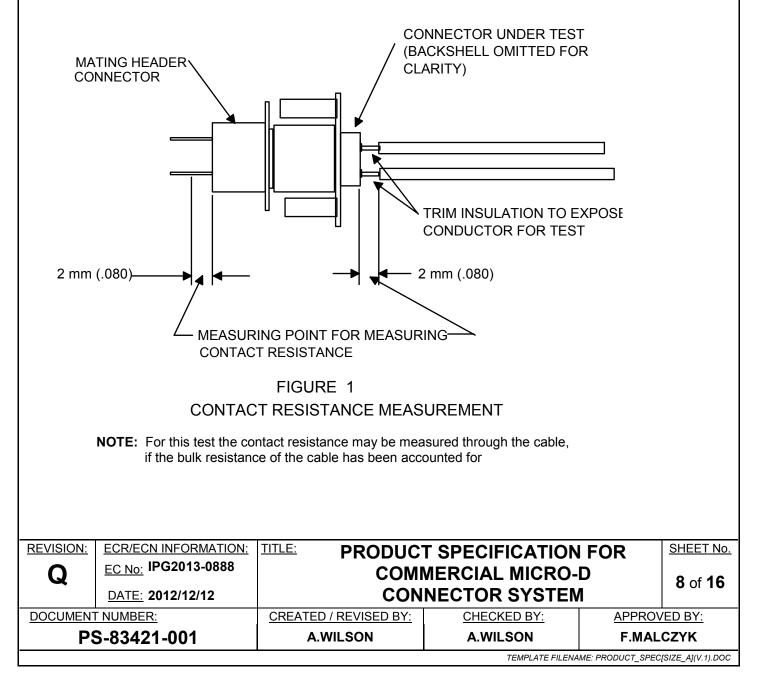
6.0 PACKAGING

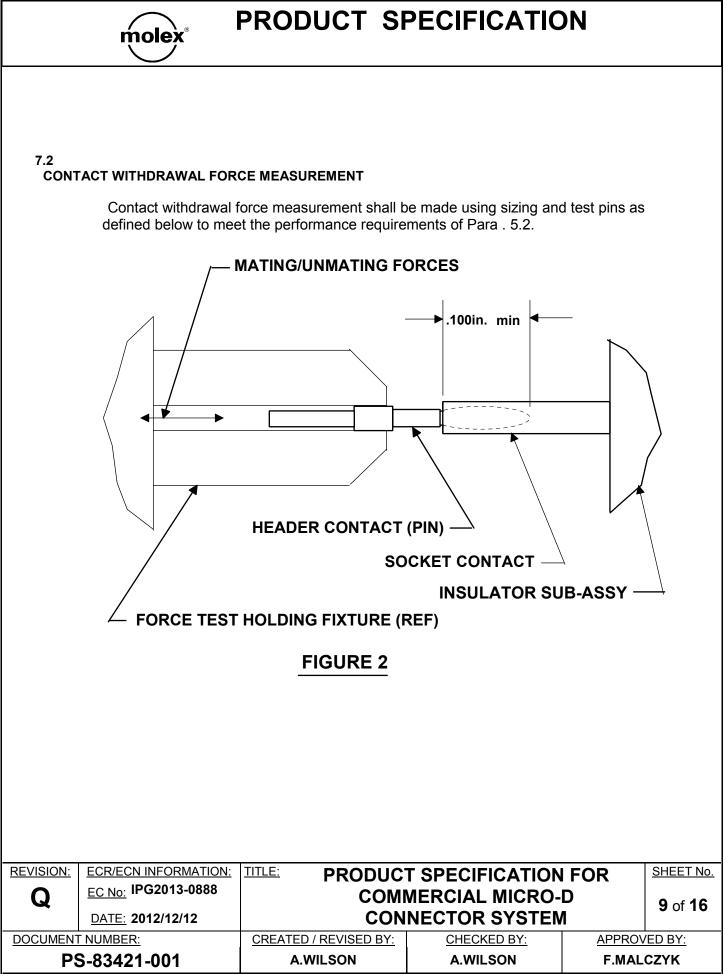
Each connector or header shall be packaged to protect against damage during handling, transit and storage.

7.0 GAGES AND FIXTURES

7.1 CONTACT RESISTANCE MEASUREMENT

Contact resistance measurements shall be made using the test setup shown in Figure 1, and shall meet the performance requirements noted in Para 5.

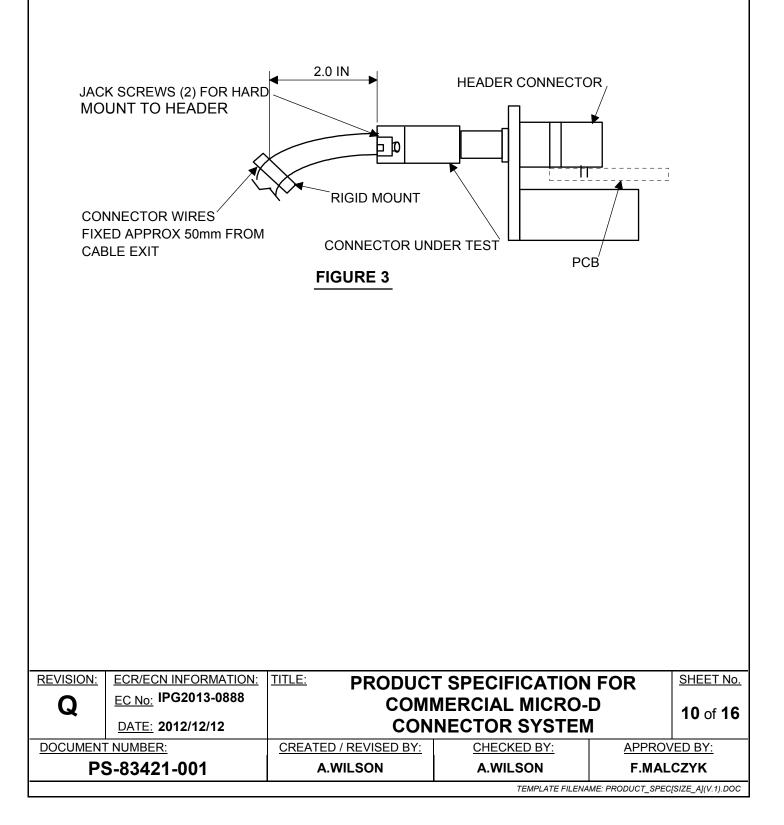






7.3 SHOCK AND VIBRATION TEST SETUP

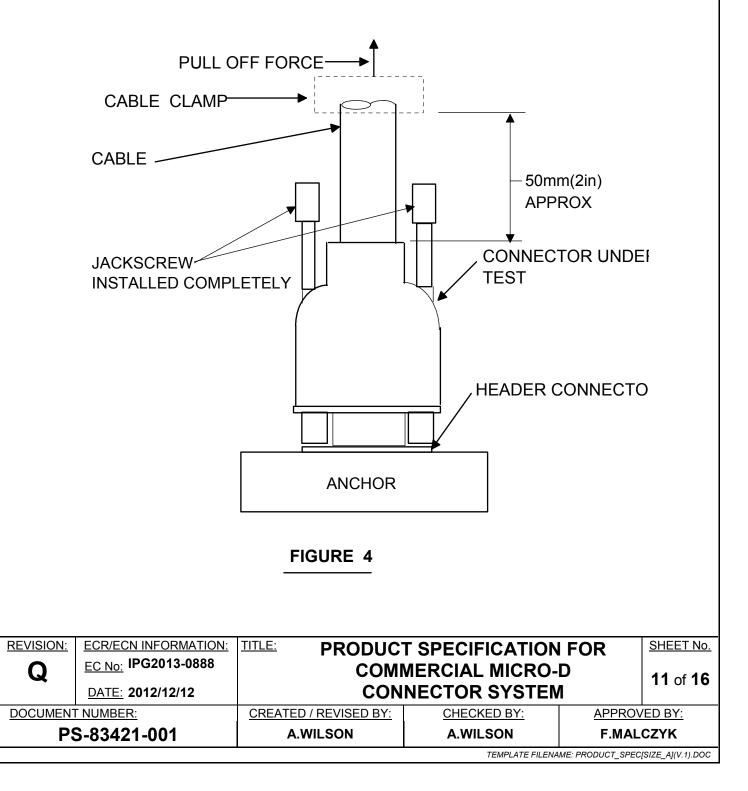
For shock and vibration testing, connector under test shall be fixtured as shown below





7.4 CABLE PULLOUT TEST REQUIREMENTS

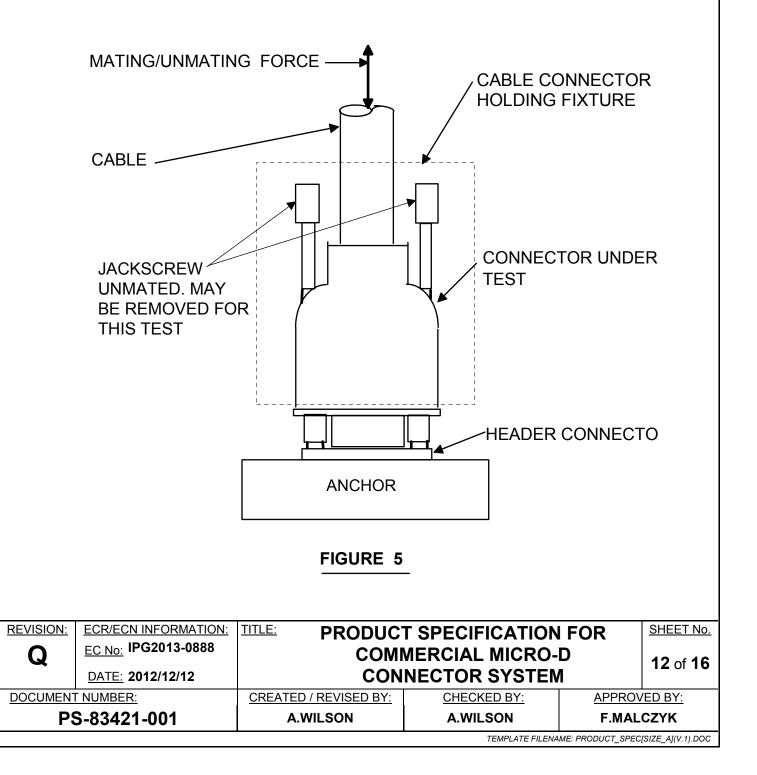
Cable pullout test measurement shall be made using the test setup shown below to meet the requirements of Para. 5.3.





7.5 CONNECTOR MATING AND UNMATING TEST REQUIREMENTS

Connector mating and unmating tests shall be made using the test setup shown below to meet the requirements of Para. 5.2.





8.0 OTHER INFORMATION

8.1 QUALITY CONFORMANCE INSPECTION

Inspection of product for delivery shall consist of Groups A and B inspections.

8.1.1 Group A Inspection

Group A inspection shall consist of the visual and mechanical inspection specified in the table below.

GROUP A INSPECTION

INSPECTION	REQUIREMENT	INSPECTION LEVEL
Visual examination	Para. 8.1.1.1	100%
Critical examination	Para. 8.1.1.2	100%

8.1.1.1 Visual examination (Group A inspection)

Each product for delivery shall be visually examined for completeness, workmanship and identification requirements. Attention shall be given to correct material, plating and obvious voids, cracks or other blemishes and defects detrimental to the function of the parts.

8.1.1.2 Critical examination (Group A inspection)

Each product for delivery shall be examined for critical (major) attributes per the individual drawing. These critical attributes shall be examined 100% for conformance to the requirements of the drawing.

Insulator subassemblies and backshell subassemblies shall also be examined for conformance to the subassembly drawings to insure the following (in-process inspection is acceptable):

- 1. Insulator subassembly latches are completely latched and there is no evidence of cracked, bent or broken latches
- 2. The two insulators are seated flush with no visible gap between their mating surfaces as a result of excessive flash or debris.
- 3. Backshell subassemblies shall be free to swivel 360 degrees without distortion of the subassembly components.

<u>REVISION:</u> Q	<u>ECR/ECN INFORMATION:</u> <u>EC No:</u> IPG2013-0888 <u>DATE:</u> 2012/12/12	COM	T SPECIFICATION MERCIAL MICRO- NECTOR SYSTEM	D	<u>SHEET No.</u> 13 of 16
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	<u>APPROV</u>	/ED BY:
PS-83421-001		A.WILSON	A.WILSON	F.MAL	СZYK
		·	TEMPLATE FILENA	ME: PRODUCT_SPEC	[SIZE_A](V.1).DOC

8.1.2 Group B inspection

mole

Group B inspection shall consist of the inspections specified in the table below, in the order shown, and shall be made on samples that have been submitted and have passed the Group A inspection. Cable assembly samples shall be assembled into single or double-ended cable assemblies of sufficient length to perform the tests noted below.

INSPECTION	REQUIREMENT	INSPECTION LEVEL
Contact resistance	4 contacts per assy. C.R.=35m Ω max. See Fig 1 for measurement points	AQL 1.0 LEVEL II
Insulation resistance	500±15Vac, 4 contacts per connector.I.R. to be >10 $^{9}\Omega$	AQL 1.0 LEVEL II
Dielectric Withstanding Voltage (DWV)	630 Vac min between pins. There shall be no evidence of breakdown or flashover.	AQL 1.0 LEVEL II
Connector mating and unmating force Measured in oz.	POSITION <u>9 15 25</u> Max Mating 165 178 238 MinUnmating 21 24 29	AQL 1.0 LEVEL II
Cable retention	25 lb min, See Para. 5.3 for test setup	AQL 1.0 LEVEL II

GROUP B INSPECTION

8.2.1.1 Contact resistance (Group B inspection)

Sample connectors from Group A inspection shall be assembled according to sales drawing assembly procedures using 83000-0002 or 83000-0069 contacts. Contacts to be conditioned 3 times using 83000-9001 contact. Contact resistance to be measured using a new not previously mated 83000-9001 contact per MIL-STD-1344, Method 3004 and Figure 1. Backshell sub-assy, boot, crimp ring and jack screws may be omitted. The 83000-9001 contacts used for conditioning are limited to 50 conditioning mates before being replaced.

8.2.1.2 Insulation resistance (Group B inspection)

Insulation resistance shall be measured on samples from Para. 8.2.1.1 according to method 3003 of MIL-STD-1344 on each contact in the connector under test. IR to be measured between closest pair of contacts and closest contact and connector shell.

REVISION:	ECR/ECN INFORMATION:	TITLE: PRODUC	T SPECIFICATION	I FOR	SHEET No.	
Q	<u>EC No:</u> IPG2013-0888	СОМІ	14 of 16			
	DATE: 2012/12/12	CON	CONNECTOR SYSTEM			
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	APPRO\	/ED BY:	
PS-83421-001		A.WILSON	A.WILSON	F.MAL	CZYK	
			TEMPLATE FILENA	ME: PRODUCT_SPEC	[SIZE_A](V.1).DOC	



8.2.1.3 Envir			1	
Solderability	Solder Time: 5 +/-0.5 secs. Solder Temperature: 260+/-	- 5°C	95% of the imm must show no v holes.	
Resistance to Soldering Heat (Through Hole)	Solder tail to be dipped in flu STD-202F method 210 cond Solder Temperature: 260 +/- Solder Time: 10 +/- 1 secs.	lition B.	No damage in a the connector	ppearance of
Resistance to IR reflow heat (SMT)	Pass product through IR mac cycles of the following reflow Average Ramp Rate Preheat Temp. (Min.) Preheat Temp. (Max.) Preheat Time Ramp to Peak Time over liquids (217°C) Peak Temperature Time within 5°C of peak Ramp – Cool Down	v profile: 3°C/sec max. 150°C 200°C 60 – 180 sec 3°C/sec max. 60 – 150 sec 260 +0/-5°C 20 – 40 sec. 6°C/sec max.	No damage in a the connector	ppearance of
	Time 25°C to Peak	8 mins. max. ature Profile		
Temp Peak Temp. Prefrest RT				Time
Peak Temp. Peinst RT Note: Please chec because the condi	Reflow Temper	ature Profile		vices before han
Peak Temp. Peinst Peinst RT Note: Please chec because the condi DN: ECR/ECN INFOR EC No: IPG2013 DATE: 2012/12/	Reflow Temper Reflow Temper S-0888	ature Profile	FICATION F L MICRO-D	vices before han OR <u>SHEE</u> 15 c
Peak Temp. Pehat Pehat RT Note: Please chec because the condi DN: ECR/ECN INFOR EC No: IPG2013	Reflow Temper Reflow Temper S-0888	ature Profile	FICATION F L MICRO-D	rices before har



8.2.1.4 Dielectric Withstanding Voltage (DWV): (Group B inspection)

DWV shall be measured on samples from Para. 8.2.1.2 according to Method 3001 of MIL-STD-1344 on each contact in the connector under test. DWV to be measured between closest pair of contacts and closest contact and connector shell.

8.2.1.5 Connector mating and unmating force (Group B inspection)

Samples from Para 8.2.1.3 shall be assembled with backshell, crimp ring, boot and jackscrews according to sales drawing assembly instructions. Mount connector in pull test fixture as shown in Figure 5 (unmated). At a feed rate of approximately 10mm/sec, mate connector under test with the mating Series 83611, 83612, or 83614 headers as appropriate until fully mated. At the same feed rate, unmate the connector from the header. Monitor mating and unmating forces continuously during mate/unmate cycle.

8.2.1.6 Cable retention (Group B inspection)

Samples from Para 8.2.1.4 shall be mounted as shown in Para 5.2, Phase 8. At a rate of approximately 10 mm/sec pull on the cable to 25 lb. minimum. The cable shall not separate from the connector sufficient to affect the performance of the connector.

9.0 Revision History

- A. See History file
- B. See History file
- C. See History file

D. Para. 2.2 and 2.4: deleted ref to specific cable and SSA standards, Para 3.0: Added MIL-STD-1344, Para 4.3, Vibration resistance: was "10-32Hz @ .35ampl; 32-500Hz @ 5g accel", TABLES I, A, B, C: corrected Requirements for Contact resistance and Voltage proof; TABLE A: changed Vibration test to Cond II, 10-500 Hz 5g accel; GROUP B INSPECTION: changed DWV to 350 Vac and 630Vac.

- E Revised mate/ummate force to 10 oz per contact
- F Updated product specification to include requirements and parameters for 15 and 25 pin configurations
- G Added Safety Agency file number and minor editorial corrections.
- H Release to work manager
- J Added 26 AWG cable
- K Added new P/Ns-Overmold, Revised insulator from LCP to Zenite
- L Revised Format
- M ADD "MATTE" TO CONTACT FINISH
- N Revise mating and Unmating Requirements.
- O Not Used
- P Remove MAX from 5.2 AND 8.1.2.
- P1 Missing data from report. Resubmit ECN

P2 Update Electrical Specification: 4.1) Dielectric Withstanding Voltage, Operating Voltage Q Added 8.2.13 Sheet No. 15 Environment Requirements

REVISION: Q	ECR/ECN INFORMATION: EC No: IPG2013-0888 DATE: 2012/12/12	COMI	T SPECIFICATION MERCIAL MICRO- NECTOR SYSTEN	D	<u>SHEET No.</u> 16 of 16
DOCUMENT NUMBER:		CREATED / REVISED BY:	CHECKED BY:	<u>APPROV</u>	/ED BY:
PS-83421-001		A.WILSON	A.WILSON	F.MAL	CZYK
			TEMPLATE FILENA	ME: PRODUCT_SPEC	[SIZE_A](V.1).DOC

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for D-Sub Cables category:

Click to view products by Molex manufacturer:

Other Similar products are found below :

1200980218 1200980067 RB09P09P-006 RB09P09P-012 RB15P15P-006 RB25P25P-006 RB37P37P-024 172-0906 SHD15P15S-012 SHD15P15S-036 SHD15P15S-060 ACL-10137-2MM RB09P09P-024 319285-3 RS422-OM2 SHD26P26S-060 SHD44P44S-036 73-6210MM-6 C200H-CN320-EU 49725A 060S2 73231-1321 SDB-50AFFM-SL7A02 49760A 060S2 HDB-26AFFM-SL7A02 30-9503P 30-9522P 73-6220MM-6 1200980058 1200980066 1200980078 1200980052 1200980093 1200980028 1200980021 1200980127 SDB-09AFFM-SL7A02 SDB-15AMMM-SL7A01 BB-LDVYCBL 83421-9286 MLDM2L-21P-6K7-18B KSFD1 MM-2J2-021-SS1-41WN HDB-78AMMM-SL7A05 SDB-37AMMM-SL7A03 SDB-15AFFM-SL7A05 ACC-500-163-R 172-1910 2900907/21.4 VS-25-DSUB-20-LI-2,0 VS-25-DSUB-20-LI-5,0